TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74LCX240F,TC74LCX240FW,TC74LCX240FT

Low-Voltage Octal Bus Buffer (inverted) with 5-V Tolerant Inputs and Outputs

The TC74LCX240F/FW/FT is a high-performance CMOS octal bus buffer. Designed for use in 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

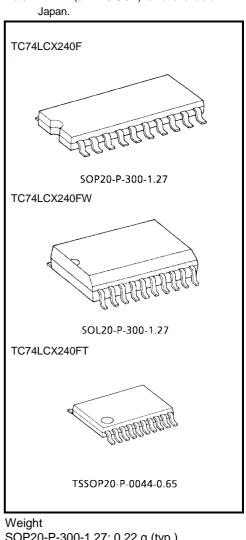
The device is designed for low-voltage (3.3 V) VCC applications, but it could be used to interface to 5-V supply environment for both inputs and outputs.

The 74LCX240F/FW/FT is an inverting 3-state buffer having two active-low output enables. This device is designed to be used with 3-state memory address drivers, etc.

All inputs are equipped with protection circuits against static discharge.

## Features

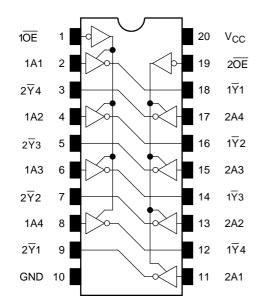
- Low-voltage operation: V<sub>CC</sub> = 2.0 to 3.6 V
- High-speed operation:  $t_{pd} = 6.5 \text{ ns} (\text{max}) (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$ •
- Ouput current:  $|I_{OH}|/I_{OL} = 24 \text{ mA} (\min) (V_{CC} = 3.0 \text{ V})$
- Latch-up performance: ±500 mA
- Available in JEDEC SOP, JEITA SOP and TSSOP
- Power-down protection provided on all inputs and outputs
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 240 type



SOP20-P-300-1.27: 0.22 g (typ.) SOL20-P-300-1.27: 0.46 g (typ.) TSSOP20-P-0044-0.65: 0.08 g (typ.)

Note: xxxFW (JEDEC SOP) is not available in

## Pin Assignment (top view)



## **Truth Table**

Inp	uts	Outputs	
ŌĒ	A <sub>n</sub>	Outputs	
L	L	Н	
L	Н	L	
Н	Х	Z	

X: Don't care

Z: High impedance

## **Maximum Ratings**

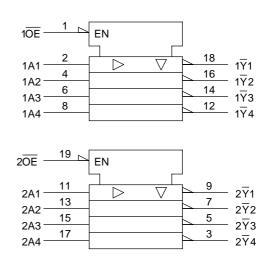
Characteristics	Symbol	Rating	Unit
Power supply voltage	V <sub>CC</sub>	-0.5 to 7.0	V
DC input voltage	V <sub>IN</sub>	-0.5 to 7.0	V
		-0.5 to 7.0 (Note 1)	
DC output voltage	Vout	-0.5 to V <sub>CC</sub> + 0.5	V
		(Note 2)	
Input diode current	l <sub>IK</sub>	-50	mA
Output diode current	I <sub>ОК</sub>	±50 (Note 3)	mA
DC output current	I <sub>OUT</sub>	±50	mA
Power dissipation	PD	180	mW
DC V <sub>CC</sub> /ground current	I <sub>CC</sub> /I <sub>GND</sub>	±100	mA
Storage temperature	T <sub>stg</sub>	–65 to 150 °	

Note 1: Output in OFF state

Note 2: High or low state. IOUT absolute maximum rating must be observed.

Note 3:  $V_{OUT} < GND, V_{OUT} > V_{CC}$ 

## **IEC Logic Symbol**



## **Recommended Operating Conditions**

Characteristics	Symbol	Rating	Unit	
Power supply voltage	2.0 to 3.6		V	
i ower supply voltage	Vcc	1.5 to 3.6 (Note 4)	v	
Input voltage	V <sub>IN</sub>	0 to 5.5	V	
Output voltage	No	0 to 5.5 (Note 5)	V	
Output voltage	Vout	0 to V <sub>CC</sub> (Note 6)		
Output current	Іон/Іог	±24 (Note 7)	mA	
Output current	IOH/IOL	±12 (Note 8)	ma	
Operating temperature	T <sub>opr</sub>	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 10 (Note 9)	ns/V	

Note 4: Data retention only

Note 5: Output in OFF state

Note 6: High or low state

Note 7:  $V_{CC} = 3.0$  to 3.6 V

Note 8:  $V_{CC} = 2.7$  to 3.0 V

Note 9:  $V_{IN} = 0.8$  to 2.0 V,  $V_{CC} = 3.0$  V

## **Electrical Characteristics**

#### DC Characteristics (Ta = -40 to 85°C)

Character	ristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit	
	H-level	VIH	-		2.7 to 3.6	2.0			
Input voltage	L-level	VIL	-		2.7 to 3.6	_	0.8	V	
				I <sub>OH</sub> = -100 μA	2.7 to 3.6	V <sub>CC</sub> - 0.2			
	H-level	V <sub>OH</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -12 \text{ mA}$	2.7	2.2			
		_		I <sub>OH</sub> = -18 mA	3.0	2.4			
Output voltage				I <sub>OH</sub> = -24 mA	3.0	2.2		V	
				I <sub>OL</sub> = 100 μA	2.7 to 3.6		0.2		
	N		I <sub>OL</sub> = 12 mA	2.7		0.4			
	L-level	$V_{OL}$ $V_{IN} = V_{IH} \text{ or } V_{IL}$ $I_{OL} = 16 \text{ mA}$	$V_{IN} = V_{IH} \text{ or } V_{IL}$	VIN = VIH OL VIL	I <sub>OL</sub> = 16 mA	3.0		0.4	
				I <sub>OL</sub> = 24 mA	3.0		0.55		
Input leakage currer	nt	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 5.5 V		2.7 to 3.6		±5.0	μA	
	ate output OFF state current		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>		2.7 to 3.6		15.0		
3-State Output OFF	state current	I <sub>OZ</sub>	$V_{OUT} = 0$ to 5.5 V		2.7 10 3.0	_	±5.0	μA	
Power-off leakage c	urrent	I <sub>OFF</sub>	$V_{IN}/V_{OUT} = 5.5 V$		0	_	10.0	μA	
Quiescent supply current			$V_{IN} = V_{CC}$ or GND		2.7 to 3.6	_	10.0		
		Icc	$V_{IN}/V_{OUT} = 3.6 \text{ to } 5.5 \text{ V}$		2.7 to 3.6		±10.0	μA	
Increase in I <sub>CC</sub> per	input	Δlcc	$V_{IH} = V_{CC} - 0.6 V$		2.7 to 3.6		500		

## AC Characteristics (Ta = -40 to 85°C)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Propagation delay time	t <sub>pLH</sub>	Figure 1, Figure 2	2.7	_	7.5	ns
r lopagation dolay time	t <sub>pHL</sub>		$\textbf{3.3}\pm\textbf{0.3}$	1.5	6.5	110
Output enable time	t <sub>pZL</sub>	Figure 1, Figure 3	2.7		9.0	ns
	t <sub>pZH</sub>		$\textbf{3.3}\pm\textbf{0.3}$	1.5	8.0	
Output disable time	t <sub>pLZ</sub>	Figure 1, Figure 3	2.7		8.0	ns
	t <sub>pHZ</sub>		$\textbf{3.3}\pm\textbf{0.3}$	1.5	7.0	115
Output to output skew	t <sub>osLH</sub>	_H (Note 10)	2.7	_	_	00
	t <sub>osHL</sub>		$\textbf{3.3}\pm\textbf{0.3}$		1.0	ns

Note 10: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$ 

#### Dynamic Switching Characteristics (Ta = 25°C, input: $t_r = t_f = 2.5$ ns, $C_L = 50$ pF, $R_L = 500 \Omega$ )

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
Quiet output maximum dynamic V <sub>OL</sub>	V <sub>OLP</sub>	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	0.8	V
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	0.8	V

## **Capacitive Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
Input capacitance	C <sub>IN</sub>	_	3.3	7	pF
Output capacitance	C <sub>OUT</sub>		3.3	8	pF
Power dissipation capacitance	C <sub>PD</sub>	f <sub>IN</sub> = 10 MHz (Note 1	1) 3.3	25	pF

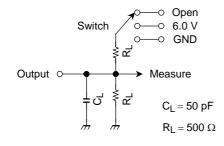
Note 11: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 (per bit)$ 

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## **AC Test Circuit**



Parameter	Switch
t <sub>pLH</sub> , t <sub>pHL</sub>	Open
t <sub>pLZ</sub> , t <sub>pZL</sub>	6.0 V
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND



## **AC Waveform**

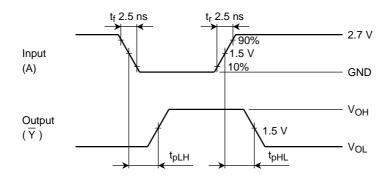


Figure 2 t<sub>pLH</sub>, t<sub>pHL</sub>

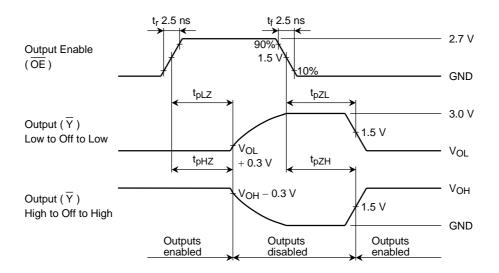
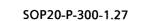
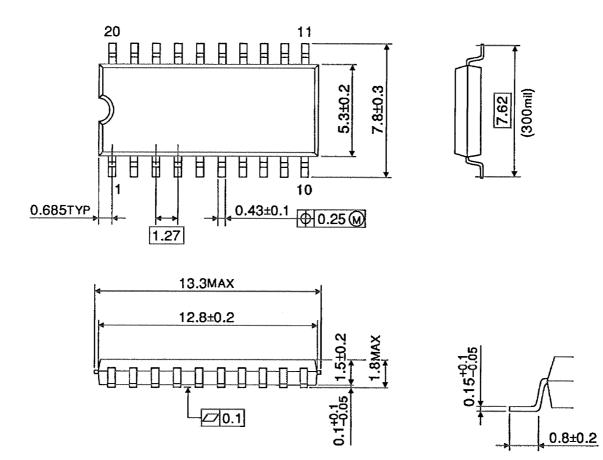


Figure 3  $t_{pLZ}, t_{pHZ}, t_{pZL}, t_{pZH}$ 

## **Package Dimensions**



Unit : mm

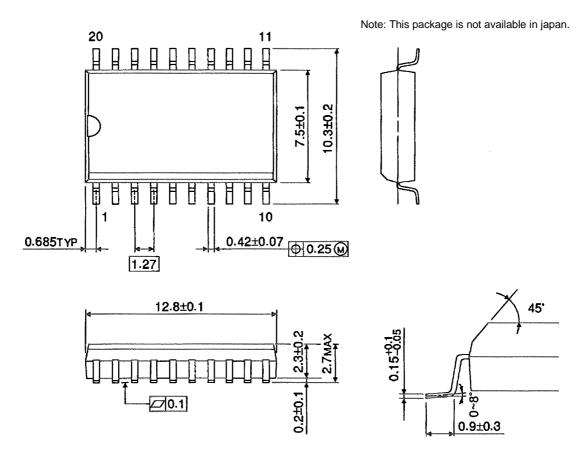


Weight: 0.22 g (typ.)

## **Package Dimensions**

SOL20-P-300-1.27

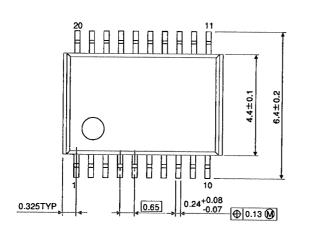
Unit : mm



Weight: 0.46 g (typ.)

## **Package Dimensions**

TSSOP20-P-0044-0.65



6.75MAX

6.5±0.1

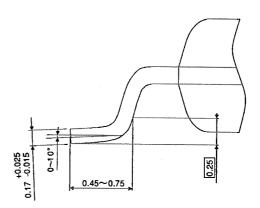
- 🔲 0.1

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1.0±0.05 1.2MAX

0.1±0.05

Unit : mm



Weight: 0.08 g (typ.)

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